

# PC901V

## Digital Output Type OPIC Photocoupler

### ■ Features

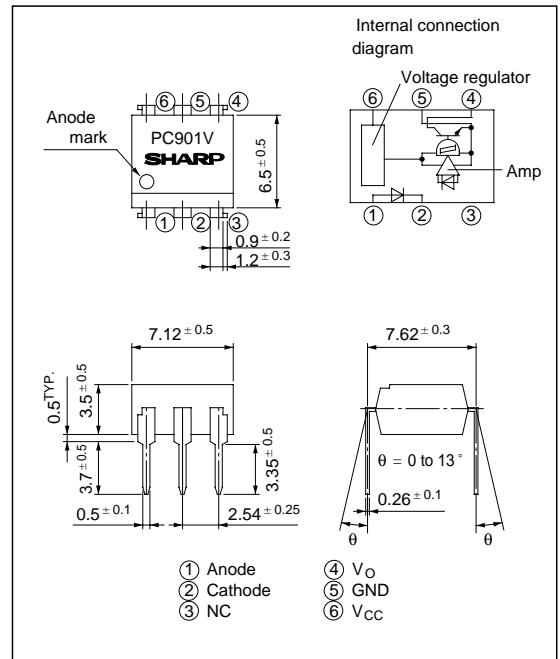
1. Normal-ON operation, open collector output
2. Operating supply voltage ( $V_{CC}$  : 3 to 15V)
3. TTL and LSTTL compatible output
4. High isolation voltage between input and output ( $V_{iso}$  : 5 000V<sub>rms</sub>)
5. High sensitivity ( $I_{FLH}$  : MAX. 2.0mA at  $T_a = 25^\circ\text{C}$ )
6. Recognized by UL, file No. 64380

### ■ Applications

1. Isolation between logic circuits
2. Logic level shifters
3. Line receivers
4. Replacements for relays and pulse transformers
5. Noise reduction

### ■ Outline Dimensions

( Unit : mm )



\* “ OPIC ” ( Optical IC ) is a trademark of the SHARP Corporation.

An OPIC consists of a light-detecting element and signal-processing circuit integrated onto a single chip.

### ■ Absolute Maximum Ratings

(  $T_a = 25^\circ\text{C}$  )

Parameter		Symbol	Rating	Unit
Input	Forward current	$I_F$	50	mA
	*1 Peak forward current	$I_{FM}$	1	A
	Reverse voltage	$V_R$	6	V
	Power dissipation	$P$	70	mW
Output	Supply voltage	$V_{CC}$	16	V
	High level output voltage	$V_{OH}$	16	V
	Low level output current	$I_{OL}$	50	mA
	Power dissipation	$P_O$	150	mW
	Total power dissipation	$P_{tot}$	170	mW
	*2 Isolation voltage	$V_{iso}$	5 000	V <sub>rms</sub>
Operating temperature	$T_{opr}$	- 25 to + 85	$^\circ\text{C}$	
Storage temperature	$T_{stg}$	- 40 to + 125	$^\circ\text{C}$	
*3 Soldering temperature	$T_{sol}$	260	$^\circ\text{C}$	

\*1 Pulse width  $\leq 100\mu\text{s}$ , Duty ratio : 0.001

\*2 40 to 60% RH, AC for 1 minute

\*3 For 10 seconds

## Electro-optical Characteristics

(Ta = 0 to + 70°C unless otherwise specified)

Parameter		Symbol	Conditions	MIN.	TYP.	MAX.	Unit	
Input	Forward voltage	$V_F$	$I_F = 4\text{mA}$	-	1.1	1.4	V	
			$I_F = 0.3\text{mA}$	0.7	1.0	-		
	Reverse current	$I_R$	$T_a = 25^\circ\text{C}, V_R = 4\text{V}$	-	-	10	$\mu\text{A}$	
	Terminal capacitance	$C_t$	$T_a = 25^\circ\text{C}, V = 0, f = 1\text{kHz}$	-	30	250	pF	
Output	Operating supply voltage	$V_{CC}$		3	-	15	V	
	Low level output voltage	$V_{OL}$	$I_{OL} = 16\text{mA}, V_{CC} = 5\text{V}, I_F = 4\text{mA}$	-	0.2	0.4	V	
	High level output current	$I_{OH}$	$V_O = V_{CC} = 15\text{V}, I_F = 0$	-	-	100	$\mu\text{A}$	
	Low level supply current	$I_{CCL}$	$V_{CC} = 5\text{V}, I_F = 0$	-	2.5	5.0	mA	
	High level supply current	$I_{CCH}$	$V_{CC} = 5\text{V}, I_F = 4\text{mA}$	-	2.7	5.5	mA	
Transfer characteristics	*4 "L→H" threshold input current	$I_{FLH}$	$T_a = 25^\circ\text{C}, V_{CC} = 5\text{V}, R_L = 280\Omega$	-	1.1	2.0	mA	
			$V_{CC} = 5\text{V}, R_L = 280\Omega$	-	-	4.0		
	*5 "H→L" threshold input current	$I_{FHL}$	$T_a = 25^\circ\text{C}, V_{CC} = 5\text{V}, R_L = 280\Omega$	0.4	0.8	-	mA	
			$V_{CC} = 5\text{V}, R_L = 280\Omega$	0.3	-	-		
	*6 Hysteresis	$I_{FHL} / I_{FLH}$	$V_{CC} = 5\text{V}, R_L = 280\Omega$	0.5	0.7	0.9	-	
	Isolation resistance		$R_{ISO}$	$T_a = 25^\circ\text{C}, \text{DC}500\text{V}, 40 \text{ to } 60\% \text{ RH}$	$5 \times 10^{10}$	$10^{11}$	-	$\Omega$
	*7 Response time	"L→H" propagation delay time	$t_{PLH}$	$T_a = 25^\circ\text{C}$ $V_{CC} = 5\text{V}, I_F = 4\text{mA}$ $R_L = 280\Omega$	-	1	3	$\mu\text{s}$
		"H→L" propagation delay time	$t_{PHL}$		-	2	6	
Rise time		$t_r$	-		0.1	0.5		
Fall time		$t_f$	-		0.05	0.5		
*8 Instantaneous common mode rejection voltage (High level output)		$CM_H$	$V_{CM} = 600\text{V (peak)}, V_O(\text{MIN.}) = 2\text{V}$ $I_F = 4\text{mA}, R_L = 280\Omega, T_a = 25^\circ\text{C}$	-	- 2000	-	$\text{V}/\mu\text{s}$	
*8 Instantaneous common mode rejection voltage (Low level output)		$CM_L$	$V_{CM} = 600\text{V (peak)}, V_O(\text{MAX.}) = 0.8\text{V}$ $I_F = 0, R_L = 280\Omega, T_a = 25^\circ\text{C}$	-	2000	-	$\text{V}/\mu\text{s}$	

\*4  $I_{FLH}$  represents forward current when output goes from low to high.

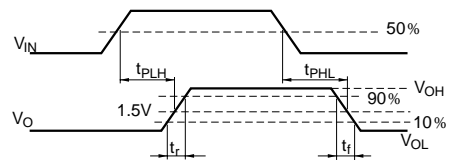
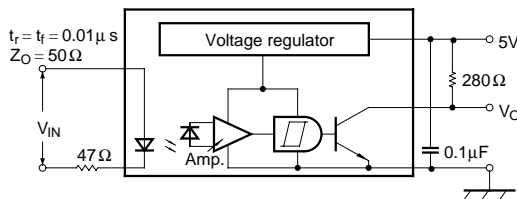
\*5  $I_{FHL}$  represents forward current when output goes from high to low.

\*6 Hysteresis stands for  $I_{FHL} / I_{FLH}$

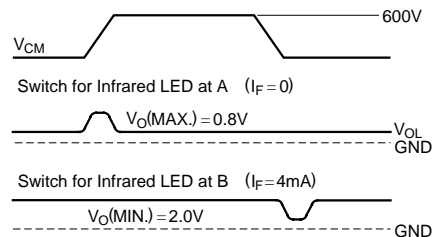
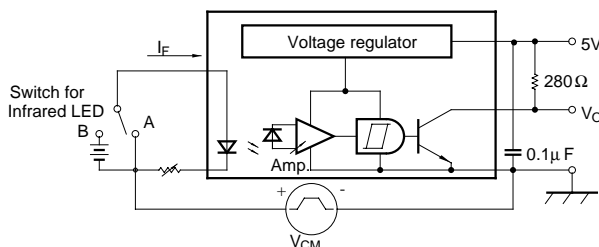
\*7 Test circuit for response time is shown below.

\*8 Test circuit for  $CM_H, CM_L$  shown below.

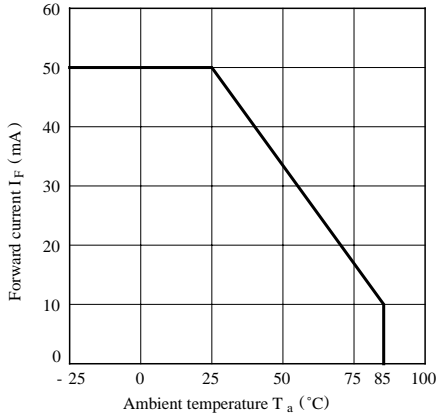
### Test Circuit for Response Time



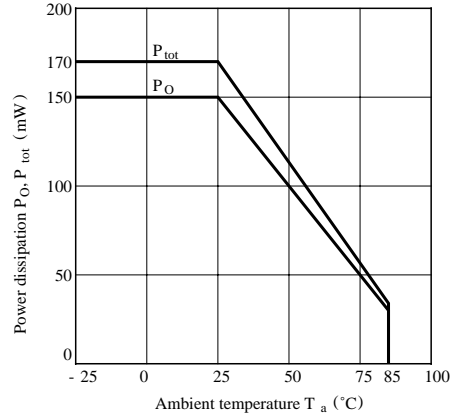
### Test Circuit for $CM_H, CM_L$



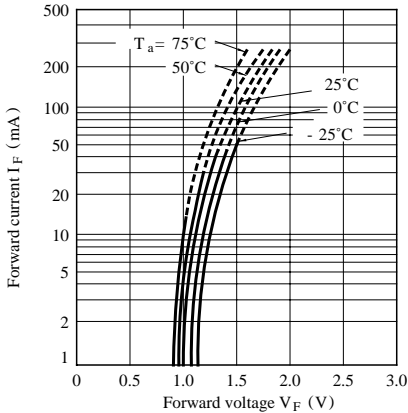
**Fig. 1 Forward Current vs. Ambient Temperature**



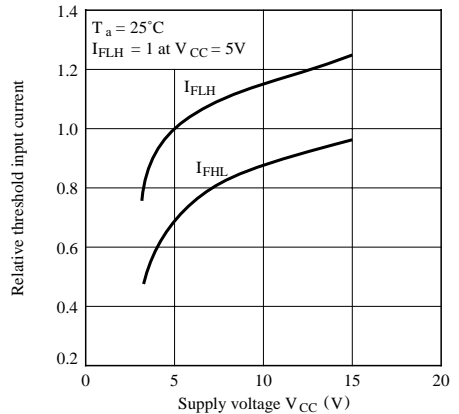
**Fig. 2 Power Dissipation vs. Ambient Temperature**



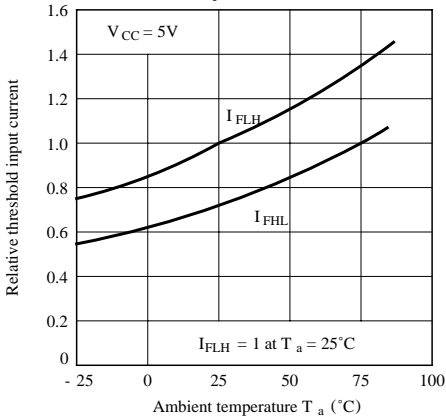
**Fig. 3 Forward Current vs. Forward Voltage**



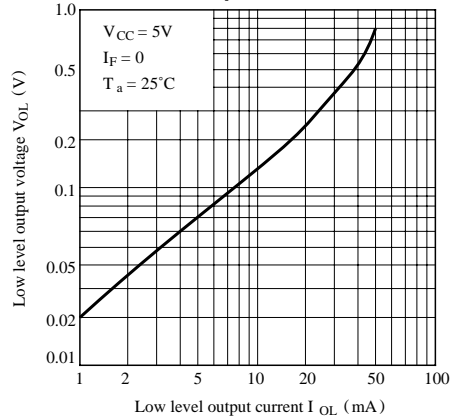
**Fig. 4 Relative Threshold Input Current vs. Supply Voltage**



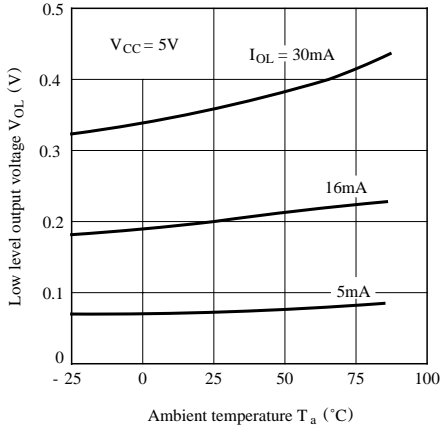
**Fig. 5 Relative Threshold Input Current vs. Ambient Temperature**



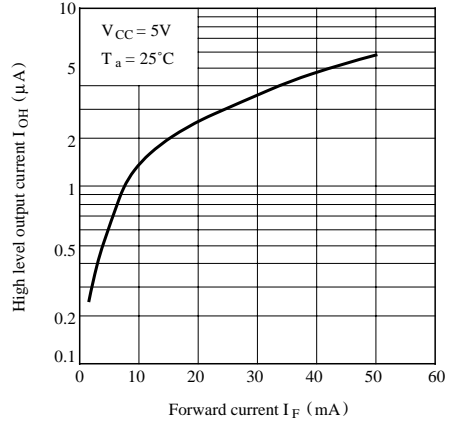
**Fig. 6 Low Level Output Voltage vs. Low Level Output Current**



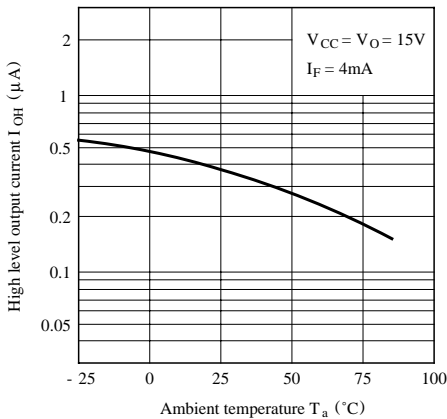
**Fig. 7 Low Level Output Voltage vs. Ambient Temperature**



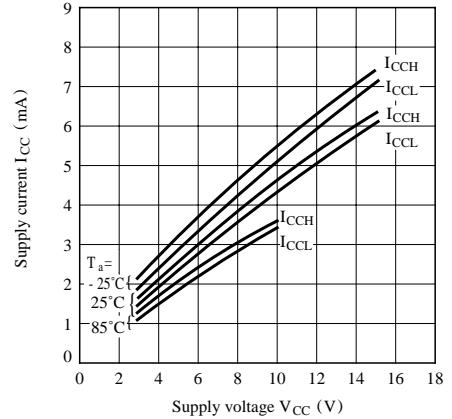
**Fig. 8 High Level Output Current vs. Forward Current**



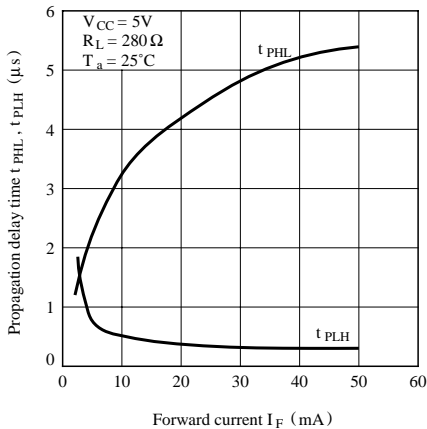
**Fig. 9 High Level Output Current vs. Ambient Temperature**



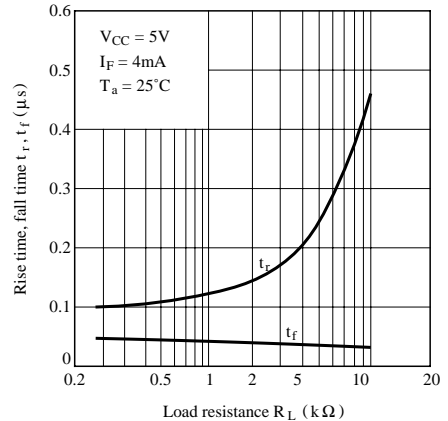
**Fig.10 Supply Current vs. Supply Voltage**



**Fig.11 Propagation Delay Time vs. Forward Current**



**Fig.12 Rise Time, Fall Time vs. Load Resistance**



**■ Precautions for Use**

- (1) It is recommended that a by-pass capacitor of more than  $0.01\ \mu\text{F}$  is added between  $V_{\text{CC}}$  and GND near the device in order to stabilize power supply line.
  - (2) Handle this product the same as with other integrated circuits against static electricity.
  - (3) As for other general cautions, please refer to the chapter “Precautions for Use”
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